Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/697,101	NAYAK ET AL.	
Examiner	Art Unit	
Tianjie Chen	2627	

	SEARCHED				
Class	Subclass	Date	Examiner		
Updated		8/13/2006	TJ		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
_				
			<u>-</u> .	
			:	
L				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
		-	
· · · · · · · · · · · · · · · · · · ·			
<u>.</u>			